Wire Wound Power Common Mode Filter WCM5555FASV-SERIES-LM

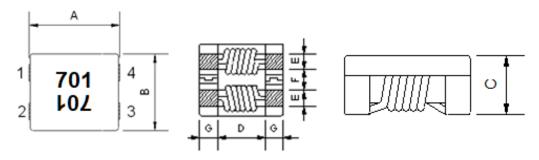
1. Features

- 1. High reliability -Reliability tests comply with AEC-Q200





2. Dimension



Series	A(mm) B(mm) C(C(mm)	C(mm) D(mm)		F(mm)	G(mm)
WCM5555	5.5±0.5	5.5±0.5	3.5 max.	3.3 typ.	1.2±0.5	1.9±0.5	1.1±0.5

Unit:mm

3. Part Numbering

WCM	5555	F	A	S	V	-	701	-	LM
Α	В	С	D	Е	F		G		Н

A: Series B: Dimension

C: Material Ferrite Core
D: Process Asembled

E: Type S=Shielded , N=Unshielded

F: Category Code V=Vehicle G: Impedance $701=700 \Omega$

H: Laser Marking

4. Specification

TAI-TECH	Impedance (Ω)		Test Frequency	DC Resistance	Rated Current	Rated Volt.	Insulation Resistance	
Part Number	min.	typ.	(MHz)	(m Ω) max. (1 line)	(A) max.	(Vdc) max.	$(M\Omega)$ min.	
WCM5555FASV-101-LM	100	140	100	6.0	8.5	80	10	
WCM5555FASV-301-LM	150	300	100	7.5	4.8	80	10	
WCM5555FASV-501-LM	300	500	100	10.5	4.5	80	10	
WCM5555FASV-701-LM	500	700	100	13.0	3.8	80	10	
WCM5555FASV-102-LM	750	1000	100	20.0	3.0	80	10	
WCM5555FASV-142-LM	1000	1400	100	38.0	2.8	80	10	

Note:

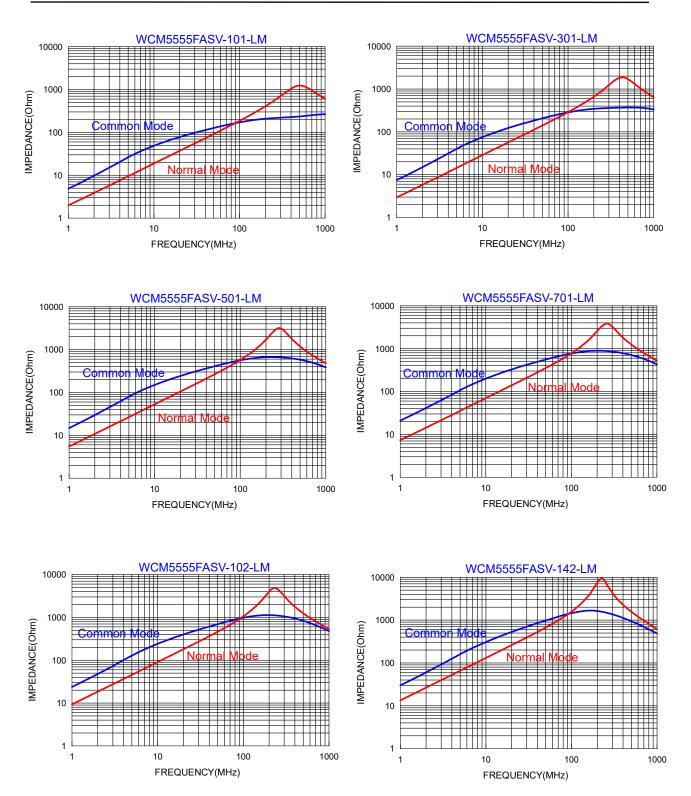
Measurement board data

Material : FR4

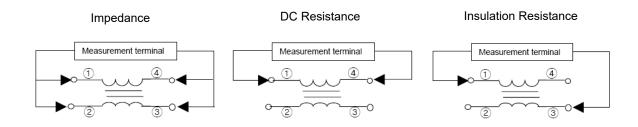
Board dimensions: 100 X 50 X 1.6t mm

Pattern dimensions: 45 X 30 mm (Double side board)

Pattern thickness : 50 μ m

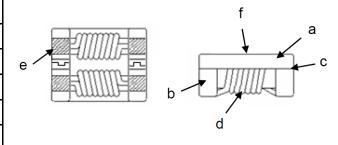


5. Schematic Diagram



6. Materials

No.	Description	Specification
a.	Upper Plate	Plastic
b.	Core	Ferrite Core
С	Adhesive	Ероху
d	Wire	Enameled Copper
е	Termination	Ag/Ni/Sn + Sn Solder
f	Mark	Laser Marking



7. Reliability and Test Condition

Item	Performance	Test Condition		
Operating temperature	-40~+125℃ (Including self - temperature rise)			
Storage temperature	-40~+125°C (on board)			
Electrical Performance Tes	st			
Z(common mode)		Agilent E4991A + Keysight 16092A		
DCR	Refer to standard electrical characteristics list.	Agilent-34420A		
I.R.		Chroma 19073		
Temperature Rise Test	Rated Current ≧ 1A ∆T 40°C Max	1.Applied the allowed DC current. 2.Temperature measured by digital surface thermometer		
Reliability Test				
High Temperature Exposure(Storage) AEC-Q200		Preconditioning: Run through reflow for 3 times.(IPC/JEDEC J-STD-020E Classification Reflow Profiles) Temperature: 125±2°C Duration: 1000hrs Min. Measured at room temperature after placing for 24±4 hrs. Preconditioning: Run through reflow for 3 times.(IPC/JEDEC		
Temperature Cycling AEC-Q200		J-STD-020E Classification Reflow Profiles) Condition for 1 cycle Step1: -40±2°C 30min Min. Step2: 125±2°C transition time 1min MAX. Step3: 125±2°C 30min Min. Step4: Low temp. Transition time 1min MAX. Number of cycles: 1000		
Moisture Resistance (AEC-Q200)	Appearance: No damage. Impedance: within±15% of initial value RDC: within ±15% of initial value and shall not exceed the specification value	t=24 hours/cycle. Note: Steps 7a & 7b not required. Unpowered. Measurement at 24±2 hours after test conclusion. 10		
Biased Humidity (AEC-Q200)		J-STD-020E Classification Reflow Profiles) Humidity : 85±3% R.H, Temperature : 85℃±2℃ Duration : 1000hrs Min. Measured at room temperature after placing for 24±4hrs.		
High Temperature Operational Life (AEC-Q200)		Agilent-34420A Chroma 19073 1.Applied the allowed DC current. 2.Temperature measured by digital surface thermometer Preconditioning: Run through reflow for 3 times. (IPC/JEDE J-STD-020E Classification Reflow Profiles) Temperature: 125±2°C Duration: 1000hrs Min. Measured at room temperature after placing for 24±4 hrs. Preconditioning: Run through reflow for 3 times. (IPC/JEDE J-STD-020E Classification Reflow Profiles) Condition for 1 cycle Step1: 40±2°C 30min Min. Step2: 125±2°C transition time 1min MAX. Step3: 125±2°C 30min Min. Step4: Low temp. Transition time 1min MAX. Number of cycles: 1000 Measured at room temperature after placing for 24±4 hrs. I=24 hours/cycle. Note: Steps 7a & 7b not required. Unpow Measurement at 24±2 hours after test conclusion. Preconditioning: Run through reflow for 3 times. (IPC/JEDE J-STD-020E Classification Reflow Profiles) Humidity: 85±3% R.H. Temperature: 85°C±2°C Duration: 1000hrs Min. Measured at room temperature after placing for 24±4hrs. Preconditioning: Run through reflow for 3 times. (IPC/JEDE J-STD-020E Classification Reflow Profiles) Temperature: 125±2°C Duration: 1000hrs Min. with 100% rated current. Measured at room temperature after placing for 24±4hrs. Inspect device construction, marking and workmanship. Element and the product specification size measurement Add aqueous wash chemical - OKEM clean or equivalent. Add aqueous wash chemical - OKEM clean or equivalent.		
External Visual	Appearance : No damage.	Inspect device construction, marking and workmanship. Electrical Test not required.		
Physical Dimension	According to the product specification size measurement	According to the product specification size measurement		
Mechanical Shock	Appearance: No damage. Impedance: within±15% of initial value RDC: within ±15% of initial value and shall not exceed the specification value	SMD 100 6 Half-sine 12.3		
	THIS SPORTS THIS	3 shocks in each direction along 3 perpendicular axes.		

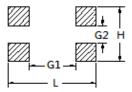
Item	Performance	Test Condition					
Vibration		Preconditioning: Run through reflow for 3 times.(IPC/JEDEC J-STD-020E Classification Reflow Profiles) Oscillation Frequency: 10Hz~2kHz~10Hz for 20 minutes Equipment: Vibration checker Total Amplitude: 5g Testing Time: 12 hours (20 minutes, 12 cycles each of 3 orientations)					
Resistance to Soldering Heat	Appearance: No damage. Impedance: within±15% of initial value RDC: within ±15% of initial value and shall not exceed the specification value	Test condition: Temperature (°C) Time(s) Temperature ramp/immersion of heat cycles 260 ±5 (solder temp) 10 ±1 25mm/s ±6 mm/s 1 Depth: completely cover the termination Continental Temperature time 25°C to peak temperature component type time 25°C to peak temperature time 2					
Thermal shock (AEC-Q200)		Trickness 2.5mm and violatines 3.0mm and violatines					
ESD	Appearance: No damage. Impedance: within±15% of initial value RDC: within ±15% of initial value and shall not exceed the specification value	Direct Contact and Air Discharge PASSIVE COMPONENT HBM ESD Discharge Waveform to a Coaxial Target Test method: AEC-Q200-002 Test mode: Contact Discharge Discharge level: 4 KV (Level: 2)					
Solderability	More than 95% of the terminal electrode should be covered with solder	a. Method B, 4hrs @155°C dry heat @235°C±5°C Testing Time: 5 +0/-0.5 seconds b. Method D category 3. (8hours ± 15 min)@ 260°C±5°C Testing Time: 30 +0/-0.5 seconds					
Electrical Characterization	Refer Specification for Approval	Summary to show Min, Max, Mean and Standard deviation.					
Flammability	Electrical Test not required.	V-0 or V-1 are acceptable.					

Item	Performance	Test Condition
Board Flex	Appearance: No damage. Impedance: within±15% of initial value RDC: within ±15% of initial value and shall not exceed the specification value	Preconditioning: Run through reflow for 3 times.(IPC/JEDEC J-STD-020E Classification Reflow Profiles) Place the 100mm X 40mm board into a fixture similar to the one shown in below Figure with the component facing down. The apparatus shall consist of mechanical means to apply a force which will bend the board (D) x = 2 mm minimum. The duration of the applied forces shall be 60 (+5) sec. The force is to be applied only once to the board. Support Solder Chip Printed circuit board before testing Printed circuit board under test Displacement Displacement
Terminal Strength(SMD)	Appearance: No damage. Impedance: within±15% of initial value RDC: within ±15% of initial value and shall not exceed the specification value	Preconditioning: Run through reflow for 3 times.(IPC/JEDEC J-STD-020E Classification Reflow Profiles) With the component mounted on a PCB with the device to be tested, apply a 17.7 N (1.8 Kg) force to the side of a device being tested. This force shall be applied for 60 +1 seconds. Also the force shall be applied gradually as not to apply a shock to the component being tested. radius 0,5 mm DUT wide thickness shear force

8. Soldering and Mounting

8-1. Recommended PC Board Pattern

	WCM5555
L(mm)	5.9
H(mm)	4.3
G1(mm	3.3
G2(mm	1.9



8-2. Soldering

Mildly activated rosin fluxes are preferred. TAI-TECH terminations are suitable for re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.

8-2.1 Soldering Reflow:

Recommended temperature profiles for lead free re-flow soldering in Figure 1. Table 1.1&1.2 (J-STD-020E)

8-2.2 Soldering Iron:

Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended. (Figure 2.)

- Never contact the ceramic with the iron tip
- Use a 20 watt soldering iron with tip diameter of 1.0mm
- 350°C tip temperature (max) • 1.0mm tip diameter (max)
- Limit soldering time to 4~5sec.

Fig.1 Soldering Reflow

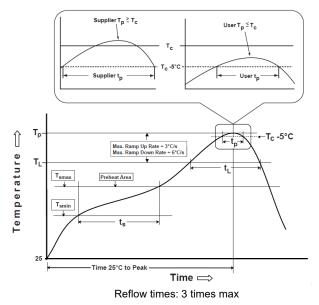
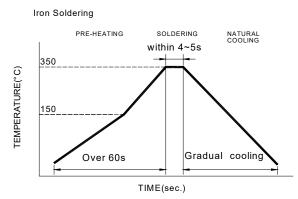


Fig.2 Iron soldering temperature profiles



Iron Soldering times: 1 times max

Table (1.1): Reflow Profiles

Profile Type:	Pb-Free Assembly
Preheat -Temperature Min(T _{smin}) -Temperature Max(T _{smax}) -Time(t _s)from(T _{smin} to T _{smax})	150°C 200°C 60-120seconds
Ramp-up rate(T_L to T_p)	3°ℂ /second max.
$\label{eq:Liquidus} \begin{array}{c} \text{Liquidus temperature}(T_L) \\ \text{Time}(t_L) \\ \text{maintained above } T_L \end{array}$	217°C 60-150 seconds
Classification temperature(T _c)	See Table (1.2)
$\label{eq:total_final} \mbox{Time}(t_p) \mbox{ at Tc-} 5^{\circ}\mbox{\mathbb{C}} (\mbox{Tp should be equal to or less than Tc.)}$	< 30 seconds
Ramp-down rate(T _p to T _L)	6°C /second max.
Time 25°C to peak temperature	8 minutes max.

Tp: maximum peak package body temperature, **Tc**: the classification temperature.

For user (customer) **Tp** should be equal to or less than **Tc**.

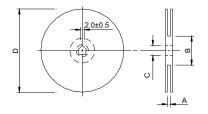
Table (1.2) Package Thickness/Volume and Classification Temperature (T_c)

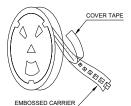
	Package	Volume mm ³	Volume mm ³	Volume mm ³
	Thickness	<350	350-2000	>2000
	<1.6mm	260°C	260°C	260°C
PB-Free Assembly	1.6-2.5mm	260°C	250°C	245°C
	≥2.5mm	250°C	245°C	245°C

Reflow is referred to standard IPC/JEDEC J-STD-020E •

9. Packaging Information

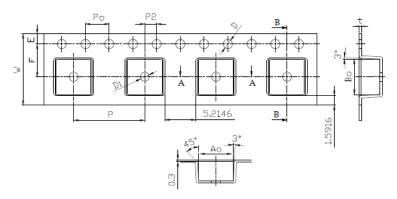
9-1. Reel Dimension





Туре	A(mm)	B(mm)	C(mm)	D(mm)	
13"x12mm	12.5±0.5	100.0±2.0	13.5±0.5	330	

9-2. Tape Dimension

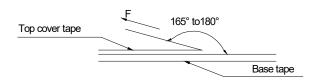


Series	W(mm)	Bo(mm)	Ao(mm)	Ko(mm)	D(mm)	D1(mm)	P0(mm)	P2(mm)	F(mm)	E(mm)	P(mm)	t(mm)
WCM5555	12.00±0.3	5.95±0.1	5.85±0.1	3.50±0.1	1.50+0.1/-0.00	1.50±0.1	4.00±0.1	2.00±0.1	5.50±0.1	1.75±0.1	12.00±0.1	0.40±0.05

9-3. Packaging Quantity

Size	Chip/Reel	Inner Box	Carton
WCM5555	1500	3000	15000

9-4. Tearing Off Force



The force for tearing off cover tape is 15 to 80 grams in the arrow direction under the following conditions.

Room Temp.	Room Humidity	Room atm	Tearing Speed
(℃)	(%)	(hPa)	mm/min
5~35	45~85	860~1060	300

Application Notice

· Storage Conditions(component level)

To maintain the solderability of terminal electrodes:

- 1. TAI-TECH products meet IPC/JEDEC J-STD-020E standard-MSL, level 1.
- 3. Recommended products should be used within 12 months form the time of delivery.
- 4. The packaging material should be kept where no chlorine or sulfur exists in the air.
- Transportation
 - 1.Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
 - 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
 - 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.